

Internet-based software for teaching test of digital circuits

Ubar, Raimund-Johannes; Orasson, Elmet; Wuttke, Heinz-Dietrich 23rd International Conference on Microelectronics : MIEL 2002, Niš, Yugoslavia, 12-15 May 2002 : proceedings. Volume 2 2002 / p. 659-662 : ill <https://ieeexplore.ieee.org/document/1003344>

Mixed-level defect simulation in data-paths of digital systems

Ubar, Raimund-Johannes; Raik, Jaan; Ivask, Eero; Brik, Marina 23rd International Conference on Microelectronics : MIEL 2002, Niš, Yugoslavia, 12-15 May 2002 : proceedings. Volume 2 2002 / p. 617-620 : ill <https://ieeexplore.ieee.org/document/1003333>

On efficient logic-level simulation of digital circuits represented by the SSBDD model

Jutman, Artur; Raik, Jaan; Ubar, Raimund-Johannes 23rd International Conference on Microelectronics : MIEL 2002, Niš, Yugoslavia, 12-15 May 2002 : proceedings. Volume 2 2002 / p. 621-624 : ill <https://ieeexplore.ieee.org/document/1003334>